Analog Engineer's Circuit

Current Limiting with Comparator Circuit

Design Goals

<table>
<thead>
<tr>
<th>LOAD CURRENT (I_L)</th>
<th>SYSTEM SUPPLY (V_S)</th>
<th>CURRENT SENSE AMP</th>
<th>COMPARATOR OUTPUT STATUS</th>
</tr>
</thead>
<tbody>
<tr>
<td>Over Current (I_OC)</td>
<td>Typical</td>
<td>Gain</td>
<td>Over Current</td>
</tr>
<tr>
<td>200 mA</td>
<td>24 V</td>
<td>20 V/V</td>
<td>V_OH = V_S</td>
</tr>
</tbody>
</table>

Design Description

This high-side, current sensing solution uses a current sense amplifier, a comparator with an integrated reference, and a P-channel MOSFET to create an over-current latch circuit. When a load current greater than 200 mA is detected, the circuit disconnects the system from its power source. Since the comparator drives the gate of the P-channel MOSFET and feeds the signal back into the reference pin of the current sense amplifier, the comparator output will latch (hold the gate source voltage of the P-channel MOSFET to 0 V) until power to the circuit is cycled.

Design Notes

1. Select a precision, current sense amplifier (INA) with an external reference pin so its output voltage can be adjusted.
2. Select a comparator with a rail-to-rail input so its output will be valid over the entire operating voltage range of the current sense amplifier.
3. Select a comparator with a push-pull output stage that can drive the gate of a MOSFET and an integrated reference to optimize circuit accuracy.
4. Create a floating 5 V supply that can power the INA and comparator.
Design Steps

1. Select the value of $R_1$ so $V_{SHUNT}$ is at least 100x greater than the current sense amplifier input offset voltage ($V_{OS}$). Note that making $R_6$ very large will improve OC detection accuracy but will reduce supply headroom and power dissipation.

\[
V_{SHUNT} = (I_{OC} \times R_1) \geq 100 \times V_{OS}
\]

Set

\[
R_1 \geq \frac{100 \times V_{OS}}{I_{OC}} = 50\,\text{m}\Omega \quad \text{for} \quad I_{OC} = 200\,\text{mA} \quad \text{and} \quad V_{OS} = 100\,\mu\text{V}
\]

2. Determine the desired gain ($A_V$) option for the INA based on the switching threshold of the comparator. When the load current ($I_L$) reaches the over-current threshold ($I_{OC}$), the INA output must cross the switching threshold ($V_{TH}$) of the comparator.

\[
V_{TH} = (I_{OC} \times R_1) \times A_V = 0.2\,\text{V}
\]

Set

\[
A_V = \frac{V_{TH}}{I_{OC} \times R_1} = \frac{0.2}{0.2 \times 0.05} = 20\,\text{V/V} \quad \text{for} \quad R_1 = 50\,\text{m}\Omega
\]

3. Since many INA's and comparators have 5 V operating voltage ranges, a 5 V supply voltage needs to be derived from the system supply $V_S$. In addition, the 5 V supply needs to float below $V_S$ so the comparator output can drive the source-gate voltage of the P-channel MOSFET to 0 V when an over-current condition occurs and 5 V when the load current is less than $I_{OC}$. The method used in this circuit is a 5 V zener diode with a 10 kΩ bias resistor ($R_2$). Other options such as shunt regulators can also be utilized as long as proper bias current through the device is maintained.

4. A low pass filter is added between the INA output and the comparator input to attenuate any high frequency current spikes. It is more important to trigger the over-current latch with a delay than to falsely disconnect the system from the supply voltage. The low pass filter is derived from $R_5$ and $C_1$. Since the switching threshold of the comparator is 0.2 V, the delay is less than 1 time constant ($R_5 \times C_1 = 5\,\text{ms}$).

5. A current limiting resistor $R_4$ is inserted between the comparator output and the gate of the P-channel MOSFET. Setting $R_4$ to 10 kΩ reduces current spikes on the supply when the comparator output needs to charge the MOSFET gate-source capacitance as a compromise to increasing the charge time. Inserting $R_4$ also serves the purpose of protecting the comparator output from any supply transients that can be present on the supply line.

6. The output of the comparator is directly connected to the REF pin of the INA in order to apply an offset to the INA's output voltage. When $I_L < I_{OC}$, the comparator output is low (equal to $V_S$-5 V) and no offset is added to the INA. However, when $I_L > I_{OC}$, the comparator output goes high (equal to $V_S$) and a 5 V offset is added to the INA. This offset causes the INA output to saturate at a level equal to $V_S$. Since an INA output level of $V_S$ is higher than the $V_{TH}$ of the comparator, the comparator output will remain high. This condition is referred to as a *latched* output state since the circuit will remain in this state until power to the circuit is cycled.

7. $R_3$ is added between the INA reference pin (REF) and GND ($V_S$-5 V) to ensure a proper ground path as the 5 V supply ramps up to the comparator minimum operating voltage.

8. If a latching feature is not preferred, the comparator output can be disconnected from the current sense amplifier reference pin and $R_3$ can be replaced with a short. In this configuration, the circuit will behave as a 200 mA current limiter.
Design Simulations

Transient Simulation Results

Design References

See Circuit SPICE Simulation File, SBVM944.

Design Featured Comparator

<table>
<thead>
<tr>
<th>TLV4041R2</th>
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</thead>
<tbody>
<tr>
<td>V&lt;sub&gt;S&lt;/sub&gt;</td>
<td>1.6 V to 5.5 V</td>
</tr>
<tr>
<td>V&lt;sub&gt;inCM&lt;/sub&gt;</td>
<td>Rail-to-rail</td>
</tr>
<tr>
<td>V&lt;sub&gt;OUT&lt;/sub&gt;</td>
<td>Push-Pull</td>
</tr>
<tr>
<td>Integrated Reference</td>
<td>200 mV ± 3 mV</td>
</tr>
<tr>
<td>I&lt;sub&gt;Q&lt;/sub&gt;</td>
<td>2 µA</td>
</tr>
<tr>
<td>t&lt;sub&gt;PD&lt;/sub&gt;</td>
<td>360 ns</td>
</tr>
</tbody>
</table>

Design Featured Current Sense Amplifier

<table>
<thead>
<tr>
<th>INA185</th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td>V&lt;sub&gt;S&lt;/sub&gt;</td>
<td>2.7 V to 5.5 V</td>
</tr>
<tr>
<td>V&lt;sub&gt;inCM&lt;/sub&gt;</td>
<td>-0.2 V to 26 V</td>
</tr>
<tr>
<td>Gain Options</td>
<td>20 V/V, 50 V/V, 100 V/V, 200 V/V</td>
</tr>
<tr>
<td>Gain Error</td>
<td>0.2 %</td>
</tr>
<tr>
<td>V&lt;sub&gt;DS&lt;/sub&gt;</td>
<td>100 µV (A1), 25 µV (A2, A3, and A4)</td>
</tr>
<tr>
<td>I&lt;sub&gt;Q&lt;/sub&gt;</td>
<td>200 µA</td>
</tr>
</tbody>
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